SAR TEST REPORT

Applicant	ZTE Corporation
FCC ID	SRQ-BLADEV8SE
Product	LTE/WCDMA/GSM (GPRS) Mutil-Mode Digital Mobile Phone
Model	ZTE BLADE V0820 /ZTE BLADE V8 LITE /ZTE BLADE V8 SE/BLADE V8 SE
Report No.	RXA1707-0241SAR01R1
Issue Date	August 16, 2017

TA Technology (Shanghai) Co., Ltd. tested the above equipment in accordance with the requirements in **IEEE 1528- 2013, ANSI/ IEEE C95.1-1992.** The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

Jiangpeng Lan　　Kai Xu

Performed by: Jiangpeng Lan　　*Approved by: Kai Xu*

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1 Test Laboratory

1.1 Notes of the Test Report

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1.2 Test facility

CNAS (accreditation number:L2264)

TA Technology (Shanghai) Co., Ltd. has obtained the accreditation of China National Accreditation Service for Conformity Assessment (CNAS).

FCC (recognition number is 428261)

TA Technology (Shanghai) Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

IC (recognition number is 8510A)

TA Technology (Shanghai) Co., Ltd. has been listed by industry Canada to perform electromagnetic emission measurement.

VCCI (recognition number is C-4595, T-2154, R-4113, G-10766)

TA Technology (Shanghai) Co., Ltd. has been listed by industry Japan to perform electromagnetic emission measurement.

A2LA (Certificate Number: 3857.01)

TA Technology (Shanghai) Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement.

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1.3 Testing Location

Company: TA Technology (Shanghai) Co., Ltd.

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City: Shanghai

Post code: 201201

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1.4 Laboratory Environment

Temperature	Min. = 18°C, Max. = 25 °C
Relative humidity	Min. = 30%, Max. = 70%
Ground system resistance	< 0.5 Ω
Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards.	

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2 Statement of Compliance

The maximum results of Specific Absorption Rate (SAR) found during testing for the EUT are as follows:

Table 2.1: Highest Reported SAR

Mode	Highest Reported SAR (W/kg)			
	1g SAR Head	1g SAR Body-worn (Separation 10mm)	1g SAR Hotspot (Separation 10mm)	Product Specific 10-g SAR (Separation 0mm)
LTE FDD 5	0.401	0.463	0.463	NA
Date of Testing:	July 25, 2017			
Note: The device is in compliance with SAR for Uncontrolled Environment /General Population exposure limits (1.6 W/kg and 4.0 W/kg) specified in ANSI/IEEE C95.1-1992, and had been tested in accordance with the measurement methods and procedures specified in IEEE 1528-2013.				

Table 2.2: Highest Simultaneous Transmission SAR

Exposure Configuration	1g SAR Head	1g SAR Body (Separation 10mm)
Highest Simultaneous Transmission SAR (W/kg)	0.905	0.559
Note: 1. The detail for simultaneous transmission consideration is described in chapter 10.3.		

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3 Description of Equipment under Test

Client Information

Applicant	ZTE Corporation
Applicant address	ZTE Plaza, Keji Road South, Hi-Tech, Industrial Park, Nanshan District, Shenzhen, Guangdong, 518057, P.R.China
Manufacturer	ZTE Corporation
Manufacturer address	ZTE Plaza, Keji Road South, Hi-Tech, Industrial Park, Nanshan District, Shenzhen, Guangdong, 518057, P.R.China

General Technologies

Application Purpose:	Original Grant
EUT Stage	Identical Prototype
Model:	ZTE BLADE V0820 /ZTE BLADE V8 LITE /ZTE BLADE V8 SE /BLADE V8 SE
IMEI:	863243030102067
Hardware Version:	uy5A
Software Version:	TEL_MX_P650F10V1.0.0B01
Antenna Type:	Internal Antenna
Device Class:	B
Wi-Fi Hotspot	Wi-Fi 2.4G
Power Class:	LTE FDD 5: 3
Power Level	LTE FDD 5:max power
EUT Accessory	
Battery	Manufacturer: ZTE Corporation Model: Li3925T44P6h765638 Power Rating: DC 3.85V, 2500mAh, Li-ion
Earphone	Model: HMZ1-CTIA3.5 1.3m，Shielded

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Wireless Technology and Frequency Range

Wireless Technology		Modulation	Operating mode	Tx (MHz)
LTE	FDD 5	QPSK, 16QAM	Rel.10	824 ~ 849
	Does this device support Carrier Aggregation (CA) ☐Yes ☒No			
	Does this device support SV-LTE (1xRTT-LTE)? ☐Yes ☒No			
BT	2.4G	Version 4.1 LE		2402 ~2480
Wi-Fi	2.4G	DSSS, OFDM	802.11b/g/n (HT20)	2402 ~2472
	Does this device support MIMO ☐Yes ☒No			

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4 Test Specification, Methods and Procedures

The tests documented in this report were performed in accordance with FCC 47 CFR § 2.1093, IEEE 1528- 2013, ANSI/IEEE C95.1-1992, the following FCC Published RF exposure KDB procedures:

447498 D01 General RF Exposure Guidance v06
648474 D04 Handset SAR v01r03
865664 D01 SAR measurement 100 MHz to 6 GHz v01r04
865664 D02 RF Exposure Reporting v01r02
941225 D05 SAR for LTE Devices v02r05
941225 D06 Hotspot Mode v02r01
941225 D05A LTE Rel.10 KDB Inquiry Sheet v01r02

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5 Operational Conditions during Test

5.1 Test Positions

5.1.1 Against Phantom Head

Measurements were made in “cheek” and “tilt” positions on both the left hand and right hand sides of the phantom.

The positions used in the measurements were according to IEEE 1528 - 2013 "IEEE Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques".

5.1.2 Body Worn Configuration

Body-worn operating configurations should be tested with the belt-clips and holsters attached to the device and positioned against a flat phantom in normal use configurations.

Body-worn operating configurations are tested with the belt-clips and holsters attached to the device and positioned against a flat phantom in a normal use configuration. Per FCC KDB Publication 648474 D04, Body-worn accessory exposure is typically related to voice mode operations when handsets are carried in body-worn accessories. The body-worn accessory procedures in FCC KDB Publication 447498 D01 should be used to test for body-worn accessory SAR compliance, without a headset connected to it. This enables the test results for such configuration to be compatible with that required for hotspot mode when the body-worn accessory test separation distance is greater than or equal to that required for hotspot mode, when applicable. When the reported SAR for a body-worn accessory, measured without a headset connected to the handset, is > 1.2 W/kg, the highest reported SAR configuration for that wireless mode and frequency band should be repeated for that body-worn accessory with a headset attached to the handset.

Accessories for Body-worn operation configurations are divided into two categories: those that do not contain metallic components and those that do contain metallic components. When multiple accessories that do not contain metallic components are supplied with the device, the device is tested with only the accessory that dictates the closest spacing to the body. Then multiple accessories that contain metallic components are tested with the device with each accessory. If multiple accessories share an identical metallic component (i.e. the same metallic belt-clip used with different holsters with no other metallic components) only the accessory that dictates the closest spacing to the body is tested.

Body-worn accessories may not always be supplied or available as options for some devices intended to be authorized for body-worn use. In this case, a test configuration with a separation distance between the back of the device and the flat phantom is used. Test position spacing was documented. Transmitters that are designed to operate in front of a person’s face, as in push-to-talk configurations, are tested for SAR compliance with the front of the device positioned to face the flat phantom in head fluid. For devices that are carried next to the body such as a shoulder, waist or chest-worn transmitters, SAR compliance is tested with the accessories, including headsets and microphones, attached to the device and positioned against a flat phantom in a normal use configuration.

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5.2 Measurement Variability

Per FCC KDB Publication 865664 D01, SAR measurement variability was assessed for each frequency band, which was determined by the SAR probe calibration point and tissue-equivalent medium used for the device measurements. When both head and body tissue-equivalent media were required for SAR measurements in a frequency band, the variability measurement procedures were applied to the tissue medium with the highest measured SAR, using the highest measured SAR configuration for that tissue-equivalent medium. These additional measurements were repeated after the completion of all measurements requiring the same head or body tissue-equivalent medium in a frequency band. The test device was returned to ambient conditions (normal room temperature) with the battery fully charged before it was re-mounted on the device holder for the repeated measurement(s) to minimize any unexpected variations in the repeated results.

SAR Measurement Variability was assessed using the following procedures for each frequency band:
1) When the original highest measured SAR is ≥ 0.80 W/kg, the measurement was repeated once.
2) A second repeated measurement was preformed only if the ratio of largest to smallest SAR for the original and first repeated measurements was > 1.20 or when the original or repeated measurement was ≥ 1.45 W/kg (~ 10% from the 1-g SAR limit).
3) A third repeated measurement was performed only if the original, first or second repeated measurement was ≥ 1.5 W/kg and the ratio of largest to smallest SAR for the original, first and second repeated measurements is > 1.20.
4) Repeated measurements are not required when the original highest measured SAR is < 0.80 W/kg

The same procedures should be adapted for measurements according to extremity and occupational exposure limits by applying a factor of 2.5 for extremity exposure and a factor of 5 for occupational exposure to the corresponding SAR thresholds.

5.3 Test Configuration

5.3.1 LTE Test Configuration

LTE modes were tested according to FCC KDB 941225 D05 publication. Please see notes after the tabulated SAR data for required test configurations. Establishing connections with base station simulators ensure a consistent means for testing SAR and are recommended for evaluating SAR [4]. The R&S CMW500 was used for LTE output power measurements and SAR testing. Max power control was used so the UE transmits with maximum output power during SAR testing. SAR must be measured with the maximum TTI (transmit time interval) supported by the device in each LTE configuration.

A) Spectrum Plots for RB Configurations

A properly configured base station simulator was used for SAR tests and power measurements. Therefore, spectrum plots for RB configurations were not required to be included in this report.

B) MPR

MPR is permanently implemented for this device by the manufacturer. The specific manufacturer target MPR is indicated alongside the SAR results. MPR is enabled for this device, according to 3GPP TS36.101 Section 6.2.3 – 6.2.5 under Table 6.2.3-1.

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C) A-MPR

A-MPR (Additional MPR) has been disabled for all SAR tests by setting NS=01 on the base station simulator.

D) Largest channel bandwidth standalone SAR test requirements

1) QPSK with 1 RB allocation

Start with the largest channel bandwidth and measure SAR for QPSK with 1 RB allocation, using the RB offset and required test channel combination with the highest maximum output power for RB offsets at the upper edge, middle and lower edge of each required test channel. When the reported SAR is ≤ 0.8 W/kg, testing of the remaining RB offset configurations and required test channels is not required for 1 RB allocation; otherwise, SAR is required for the remaining required test channels and only for the RB offset configuration with the highest output power for that channel. When the reported SAR of a required test channel is > 1.45 W/kg, SAR is required for all three RB offset configurations for that required test channel.

2) QPSK with 50% RB allocation

The procedures required for 1 RB allocation in 1) are applied to measure the SAR for QPSK with 50% RB allocation.

3) QPSK with 100% RB allocation

For QPSK with 100% RB allocation, SAR is not required when the highest maximum output power for 100 % RB allocation is less than the highest maximum output power in 50% and 1 RB allocations and the highest reported SAR for 1 RB and 50% RB allocation in 1) and 2) are ≤ 0.8 W/kg. Otherwise, SAR is measured for the highest output power channel and if the reported SAR is > 1.45 W/kg, the remaining required test channels must also be tested.

4) Higher order modulations

For each modulation besides QPSK; e.g., 16-QAM, 64-QAM, apply the QPSK procedures in above sections to determine the QAM configurations that may need SAR measurement. For each configuration identified as required for testing, SAR is required only when the highest maximum output power for the configuration in the higher order modulation is > ½ dB higher than the same configuration in QPSK or when the reported SAR for the QPSK configuration is > 1.45 W/kg.

E) Other channel bandwidth standalone SAR test requirements

For the other channel bandwidths used by the device in a frequency band, apply all the procedures required for the largest channel bandwidth in section A) to determine the channels and RB configurations that need SAR testing and only measure SAR when the highest maximum output power of a configuration requiring testing in the smaller channel bandwidth is > ½ dB higher than the equivalent channel configurations in the largest channel bandwidth configuration or the *reported* SAR of a configuration for the largest channel bandwidth is > 1.45 W/kg.

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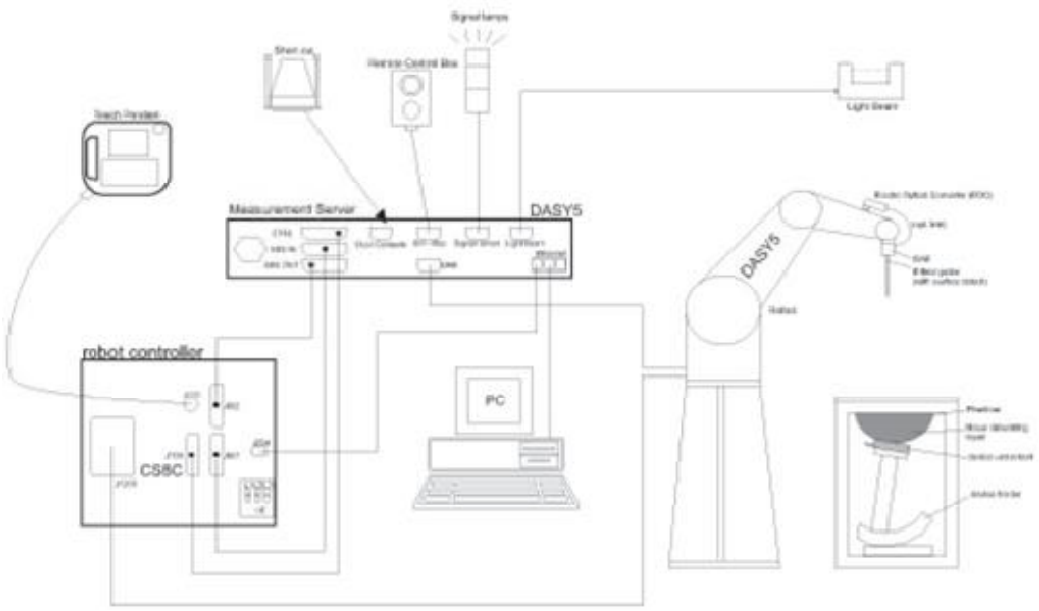
6 SAR Measurements System Configuration

6.1 SAR Measurement Set-up

The DASY system for performing compliance tests consists of the following items:



- A standard high precision 6-axis robot with controller, teach pendant and software. An arm extension for accommodating the data acquisition electronics (DAE).
- An isotropic Field probe optimized and calibrated for the targeted measurement.
- A data acquisition electronics (DAE) which performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.
- The Electro-optical converter (EOC) performs the conversion from optical to electrical signals for the digital communication to the DAE. To use optical surface detection, a special version of the EOC is required. The EOC signal is transmitted to the measurement server.
- The function of the measurement server is to perform the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- The Light Beam used is for probe alignment. This improves the (absolute) accuracy of the probe positioning.
- A computer running WinXP or Win7 and the DASY software.
- Remote control and teach pendant as well as additional circuitry for robot safety such as warning lamps, etc.
- The phantom, the device holder and other accessories according to the targeted measurement.

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6.2 DASY5 E-field Probe System

The SAR measurements were conducted with the dosimetric probe EX3DV4 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation.

EX3DV4 Probe Specification

Construction	Symmetrical design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)
Calibration	ISO/IEC 17025 calibration service available
Frequency	10 MHz to > 6 GHz Linearity: ± 0.2 dB (30 MHz to 6 GHz)
Directivity	± 0.3 dB in HSL (rotation around probe axis) ± 0.5 dB in tissue material (rotation normal to probe axis)
Dynamic Range	10 μW/g to > 100 mW/g Linearity: ± 0.2dB (noise: typically < 1 μW/g)
Dimensions	Overall length: 330 mm (Tip: 20 mm) Tip diameter: 2.5 mm (Body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm
Application	High precision dosimetric measurements in any exposure Scenario (e.g., very strong gradient fields). Only probe which enables compliance testing for frequencies up to 6 GHz with precision of better 30%.

E-field Probe Calibration

Each probe is calibrated according to a dosimetric assessment procedure with accuracy better than ± 10%. The spherical isotropy was evaluated and found to be better than ± 0.25dB. The sensitivity parameters (NormX, NormY, NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested.

The free space E-field from amplified probe outputs is determined in a test chamber. This is performed in a TEM cell for frequencies bellow 1 GHz, and in a wave guide above 1 GHz for free space. For the free space calibration, the probe is placed in the volumetric center of the cavity and at the proper orientation with the field. The probe is then rotated 360 degrees.

E-field temperature correlation calibration is performed in a flat phantom filled with the appropriate simulated brain tissue. The measured free space E-field in the medium correlates to temperature rise in a dielectric medium. For temperature correlation calibration a RF transparent thermistor-based

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temperature probe is used in conjunction with the E-field probe.

SAR=C∆T/∆t

Where: ∆t = Exposure time (30 seconds),

C = Heat capacity of tissue (brain or muscle),

∆T = Temperature increase due to RF exposure.

Or

SAR=$|E|^2\sigma/\rho$

Where: σ = Simulated tissue conductivity,

ρ = Tissue density (kg/m^3).

6.3 SAR Measurement Procedure

Power Reference Measurement

The Power Reference Measurement and Power Drift Measurements are for monitoring the power drift of the device under test in the batch process. The minimum distance of probe sensors to surface determines the closest measurement point to phantom surface. This distance cannot be smaller than the distance of sensor calibration points to probe tip as defined in the probe properties.

Area Scan

The area scan is used as a fast scan in two dimensions to find the area of high field values, before doing a fine measurement around the hot spot. The sophisticated interpolation routines implemented in DASY software can find the maximum found in the scanned area, within a range of the global maximum. The range (in dB) is specified in the standards for compliance testing. For example, a 2 dB range is required in IEEE standard 1528 and IEC 62209 standards, whereby 3 dB is a requirement when compliance is assessed in accordance with the ARIB standard (Japan), if only one zoom scan follows the area scan, then only the absolute maximum will be taken as reference. For cases where multiple maximums are detected, the number of zoom scans has to be increased accordingly.

Area scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

	≤3 GHz	> 3 GHz
Maximum distance from closest measurement point (geometric center of probe sensors) to phantom surface	5 ± 1 mm	½·δ·ln(2) ± 0.5 mm
Maximum probe angle from probe axis to phantom surface normal at the measurement location	30° ± 1°	20° ± 1°
Maximum area scan spatial resolution: ΔxArea, ΔyArea	≤ 2 GHz: ≤ 15 mm 2 – 3 GHz: ≤ 12 mm	3 – 4 GHz: ≤ 12 mm 4 – 6 GHz: ≤ 10 mm
	When the x or y dimension of the test device, in the measurement plane orientation, is smaller than the above, the measurement resolution must be ≤ the corresponding x or y dimension of the test device with at least one measurement point on the test device.	

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Zoom Scan

Zoom scans are used assess the peak spatial SAR values within a cubic averaging volume containing 1 gram and 10 gram of simulated tissue. The zoom scan measures points (refer to table below) within a cube shoes base faces are centered on the maxima found in a preceding area scan job within the same procedure. When the measurement is done, the zoom scan evaluates the averaged SAR for 1 gram and 10 gram and displays these values next to the job's label.

Zoom scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

			≤3GHz	> 3 GHz
Maximum zoom scan spatial resolution: $\triangle x_{zoom}$ $\triangle y_{zoom}$			≤2GHz: ≤8mm 2 – 3GHz: ≤5mm*	3 – 4GHz: ≤5mm* 4 – 6GHz: ≤4mm*
Maximum zoom scan spatial resolution, normal to phantom surface	Uniform grid: $\triangle z_{zoom}(n)$		≤5mm	3 – 4GHz: ≤4mm 4 – 5GHz: ≤3mm 5 – 6GHz: ≤2mm
	Graded grid	$\triangle z_{zoom}(1)$: between 1st two points closest to phantom surface	≤4mm	3 – 4GHz: ≤3mm 4 – 5GHz: ≤2.5mm 5 – 6GHz: ≤2mm
		$\triangle z_{zoom}(n>1)$: between subsequent points	$\leq 1.5 \cdot \triangle z_{zoom}(n-1)$	
Minimum zoom scan volume	X, y, z		≥30mm	3 – 4GHz: ≥28mm 4 – 5GHz: ≥25mm 5 – 6GHz: ≥22mm

Note: δ is the penetration depth of a plane-wave at normal incidence to the tissue medium; see draft standard IEEE P1528-2011 for details.

* When zoom scan is required and the *reported* SAR from the *area scan based 1-g SAR estimation* procedures of KDB 447498 is ≤ 1.4W/kg, ≤8mm, ≤7mm and ≤5mm zoom scan resolution may be applied, respectively, for 2GHz to 3GHz, 3GHz to 4GHz and 4GHz to 6GHz.

Volume Scan Procedures

The volume scan is used for assess overlapping SAR distributions for antennas transmitting in different frequency bands. It is equivalent to an oversized zoom scan used in standalone measurements. The measurement volume will be used to enclose all the simultaneous transmitting antennas. For antennas transmitting simultaneously in different frequency bands, the volume scan is measured separately in each frequency band. In order to sum correctly to compute the 1g aggregate SAR, the EUT remain in the same test position for all measurements and all volume scan use the same spatial resolution and grid spacing. When all volume scan were completed, the software, SEMCAD postprocessor can combine and subsequently superpose these measurement data to calculating the multiband SAR.

Power Drift Monitoring

All SAR testing is under the EUT install full charged battery and transmit maximum output power. In DASY measurement software, the power reference measurement and power drift measurement procedures are used for monitoring the power drift of EUT during SAR test. Both these procedures measure the field at a specified reference position before and after the SAR testing. The software will calculate the field difference in dB. If the power drifts more than 5%, the SAR will be retested.

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7 Main Test Equipment

Name of Equipment	Manufacturer	Type/Model	Serial Number	Last Cal.	Cal. Due Date
Network analyzer	Agilent	E5071B	MY42404014	2017-05-20	2018-05-19
Dielectric Probe Kit	HP	85070E	US44020115	2017-05-20	2018-05-19
Power meter	Agilent	E4417A	GB41291714	2017-05-21	2018-05-20
Power sensor	Agilent	N8481H	MY50350004	2017-05-21	2018-05-20
Power sensor	Agilent	E9327A	US40441622	2017-05-20	2018-05-19
Dual directional coupler	Agilent	778D-012	50519	2017-05-21	2018-05-20
Amplifier	INDEXSAR	IXA-020	0401	2017-05-20	2018-05-19
Wideband radio communication tester	R&S	CMW 500	113645	2017-05-20	2018-05-19
BT Base Station Simulator	R&S	CBT	100271	2017-05-14	2018-05-13
E-field Probe	SPEAG	EX3DV4	3677	2017-01-23	2018-01-22
DAE	SPEAG	DAE4	1317	2016-08-02	2017-08-01
Validation Kit 835MHz	SPEAG	D835V2	4d020	2014-08-28	2017-08-27
Temperature Probe	Tianjin jinming	JM222	AA1009129	2017-05-20	2018-05-19
Hygrothermograph	Anymetr	NT-311	20150731	2017-05-17	2018-05-16

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8 Tissue Dielectric Parameter Measurements & System Verification

8.1 Tissue Verification

The temperature of the tissue-equivalent medium used during measurement must also be within 18°C to 25°C and within ± 2°C of the temperature when the tissue parameters are characterized. The dielectric parameters must be measured before the tissue-equivalent medium is used in a series of SAR measurements. The parameters should be re-measured after each 3 – 4 days of use; or earlier if the dielectric parameters can become out of tolerance.

Target values

Frequency (MHz)		Water (%)	Salt (%)	Sugar (%)	Glycol (%)	Preventol (%)	Cellulose (%)	ε_r	σ(s/m)
Head	835	41.45	1.45	56	0	0.1	1.0	41.5	0.90
Body	835	52.5	1.4	45	0	0.1	1.0	55.2	0.97

Measurements results

Frequency (MHz)		Test Date	Temp ℃	Measured Dielectric Parameters		Target Dielectric Parameters		Limit (Within ±5%)	
				ε_r	σ(s/m)	ε_r	σ(s/m)	Dev ε_r(%)	Dev σ(%)
835	Head	7/25/2017	21.5	42.5	0.94	41.5	0.90	2.41	4.44
	Body	7/25/2017	21.5	55.4	0.96	55.2	0.97	0.36	-1.03
Note: The depth of tissue-equivalent liquid in a phantom must be ≥ 15.0 cm for SAR measurements ≤ 3 GHz and ≥ 10.0 cm for measurements > 3 GHz.									

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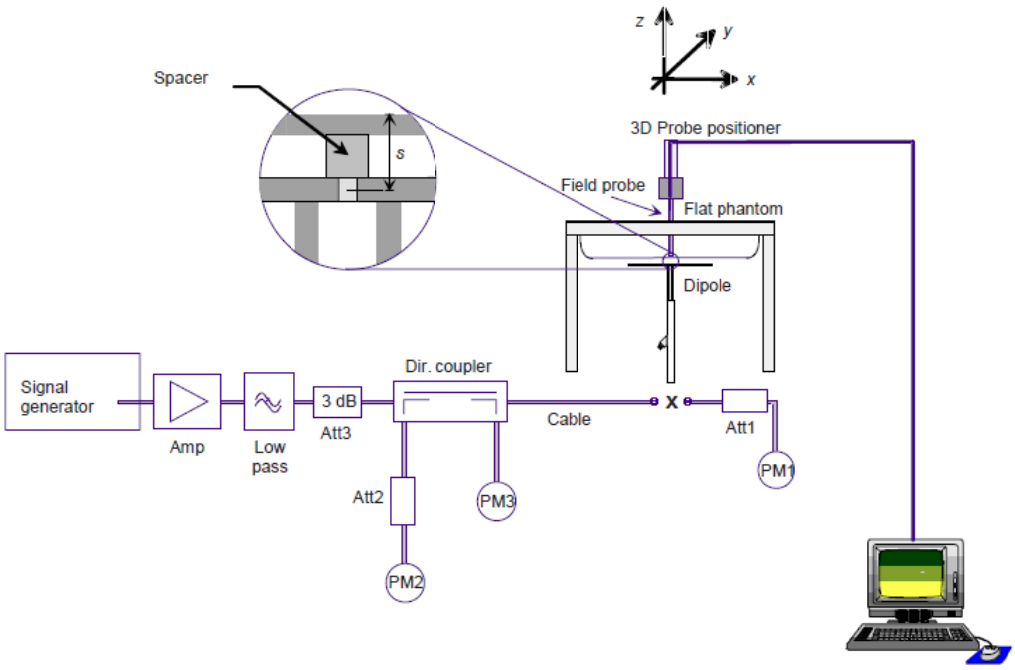
8.2 System Performance Check

The manufacturer calibrates the probes annually. Dielectric parameters of the tissue simulates were measured using the dielectric probe kit and the network analyzer. A system check measurement for every day was made following the determination of the dielectric parameters of the Tissue simulates, using the dipole validation kit. The dipole antenna was placed under the flat section of the twin SAM phantom.

System check is performed regularly on all frequency bands where tests are performed with the DASY system.



Picture 1 System Performance Check setup

Picture 2 Setup Photo

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Justification for Extended SAR Dipole Calibrations

Usage of SAR dipoles calibrated less than 3 years ago but more than 1 year ago were confirmed in maintaining return loss (< - 20 dB, within 20% of prior calibration) and impedance (within 5 ohm from prior calibration) requirements per extended calibrations in KDB 865664 D01:

Dipole		Date of Measurement	Return Loss(dB)	Δ %	Impedance (Ω)	ΔΩ
Dipole D835V2 SN: 4d020	Head Liquid	8/28/2014	-30.1	/	48.6	/
		8/27/2015	-31.1	3.3%	49.7	1.1Ω
		8/26/2016	-32.2	-3.4%	49.8	0.1Ω
	Body Liquid	8/28/2014	-23.3	/	54.0	/
		8/27/2015	-23.9	2.6%	53.5	0.5Ω
		8/26/2016	-24.2	-1.2%	53.1	0.4Ω

System Check results

Frequency (MHz)		Test Date	Temp ℃	250mW Measured SAR_{1g} (W/kg)	1W Normalized SAR_{1g} (W/kg)	1W Target SAR_{1g} (W/kg)	Δ % (Limit ±10%)	Plot No.
835	Head	7/25/2017	21.5	2.44	9.76	9.54	2.31	1
	Body	7/25/2017	21.5	2.41	9.64	9.54	1.05	2
Note：Target Values used derive from the calibration certificate Data Storage and Evaluation.								

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9 Normal and Maximum Output Power

KDB 447498 D01 at the maximum rated output power and within the tune-up tolerance range specified for the product, but not more than 2 dB lower than the maximum tune-up tolerance limit.

9.1 LTE Mode

UE Power Class: 3 (23 +/- 2dBm). The allowed Maximum Power Reduction (MPR) for the maximum output power due to higher order modulation and transmit bandwidth configuration (resource blocks) is specified in Table 6.2.3-1 of the 3GPP TS36.101.

Table 6.2.3-1: Maximum Power Reduction (MPR) for Power Class 3

Modulation	Channel bandwidth / Transmission bandwidth (N_{RB})						MPR (dB)
	1.4 MHz	3.0 MHz	5 MHz	10 MHz	15 MHz	20 MHz	
QPSK	> 5	> 4	> 8	> 12	> 16	> 18	≤ 1
16 QAM	≤ 5	≤ 4	≤ 8	≤ 12	≤ 16	≤ 18	≤ 1
16 QAM	> 5	> 4	> 8	> 12	> 16	> 18	≤ 2

LTE FDD Band 5				Conducted Power(dBm)			Tune-up Limit (dBm)
Bandwidth	Modulation	RB size	RB offset	Channel/Frequency (MHz)			
				20407/824.7	20525/836.5	20643/848.3	
1.4MHz	QPSK	1	0	22.89	22.89	22.92	23.50
		1	2	22.87	22.84	22.91	
		1	5	22.93	22.89	22.96	
		3	0	22.75	22.92	22.85	23.50
		3	2	22.80	22.88	22.84	
		3	3	22.82	22.79	22.74	
		6	0	21.80	21.96	21.89	22.50
	16QAM	1	0	22.06	21.88	22.05	22.50
		1	2	21.87	21.94	22.04	
		1	5	21.98	21.91	22.01	
		3	0	21.75	21.84	21.88	22.50
		3	2	21.84	21.82	21.82	
		3	3	21.80	21.79	21.72	
		6	0	20.84	20.96	20.91	21.50
Bandwidth	Modulation	RB size	RB offset	Channel/Frequency (MHz)			Tune-up Limit (dBm)
				20415/825.5	20525/836.5	20635/847.5	
3MHz	QPSK	1	0	22.91	22.93	22.95	23.50
		1	7	22.90	22.89	22.95	
		1	14	22.96	22.94	23.00	
		8	0	21.85	22.04	21.98	22.50
		8	4	21.92	21.98	21.96	

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		8	7	21.92	21.90	21.84	
		15	0	21.83	22.00	21.92	22.50
	16QAM	1	0	22.09	21.90	22.08	22.50
		1	7	21.90	21.99	22.08	
		1	14	22.00	21.95	22.04	
		8	0	20.86	20.97	21.00	21.50
		8	4	20.95	20.95	20.94	
		8	7	20.90	20.91	20.85	
		15	0	20.87	21.00	20.94	21.50
Bandwidth	Modulation	RB size	RB offset	Channel/Frequency (MHz)			Tune-up Limit (dBm)
				20425/826.5	20525/836.5	20625/846.5	
5MHz	QPSK	1	0	22.88	22.91	22.91	23.50
		1	13	22.88	22.85	22.92	
		1	24	22.93	22.89	22.96	
		12	0	21.82	21.99	21.94	22.50
		12	6	21.90	21.94	21.91	
		12	13	21.90	21.88	21.80	
		25	0	21.81	21.99	21.90	22.50
	16QAM	1	0	22.06	21.86	22.05	22.50
		1	13	21.87	21.97	22.05	
		1	24	21.97	21.93	22.00	
		12	0	20.84	20.93	20.97	21.50
		12	6	20.92	20.90	20.90	
		12	13	20.87	20.86	20.81	
		25	0	20.85	20.96	20.89	21.50
Bandwidth	Modulation	RB size	RB offset	Channel/Frequency (MHz)			Tune-up Limit (dBm)
				20450/829	20525/836.5	20600/844	
10MHz	QPSK	1	0	22.86	22.84	22.89	23.50
		1	25	22.88	22.85	22.91	
		1	49	22.90	22.87	22.92	
		25	0	21.80	21.95	21.91	22.50
		25	13	21.88	21.90	21.88	
		25	25	21.86	21.84	21.77	
		50	0	21.84	21.92	21.85	22.50
	16QAM	1	0	22.01	21.83	22.00	22.50
		1	25	21.84	21.96	22.02	
		1	49	21.95	21.88	21.98	
		25	0	20.81	20.92	20.95	21.50
		25	13	20.88	20.87	20.86	
		25	25	20.85	20.82	20.78	
		50	0	20.83	20.92	20.86	21.50

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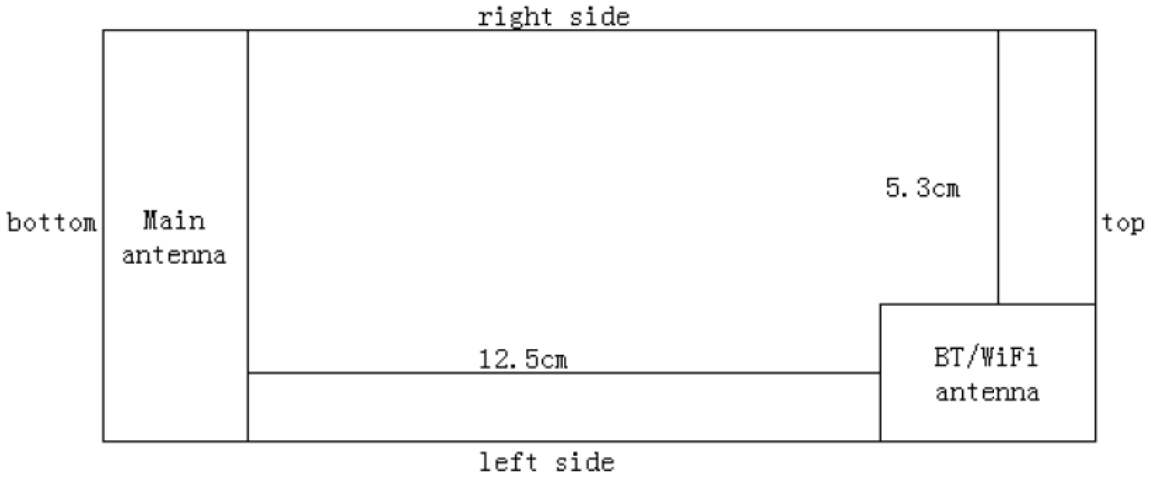
10 Measured and Reported (Scaled) SAR Results

10.1 EUT Antenna Locations



Picture of antennas

SAR is measured for all edges and surfaces of the device with a transmitting antenna located within 25 mm from that surface or edge.

Hotspot mode, Positions for SAR tests						
Mode	Back Side	Front side	Left Edge	Right Edge	Top Edge	Bottom Edge
LTE 5	Yes	Yes	Yes	Yes	12.5cm>2.5cm	Yes
Note: 1. Per KDB 941225 D06, when the overall device length and width are ≥ 9cm*5cm, the test distance is 10mm. SAR must be measured for all sides and surfaces with a transmitting antenna located within 25mm from that surface or edge.						

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10.2 Measured SAR Results

Table 1: LTE Band 5 (10MHz)

Test Position	Cover Type	RB size	RB offset	Channel/ Frequency (MHz)	Maximum Allowed Power (dBm)	Conducted Power (dBm)	Drift (dB)	Measured SAR_{1g} (W/kg)	Scaling Factor	Reported SAR_{1g} (W/kg)	Plot No.
Head SAR (QPSK)											
Left Cheek	standard	1RB	49	20600/844	23.50	22.92	0.021	0.320	1.14	0.366	/
Left Tilt	standard	1RB	49	20600/844	23.50	22.92	0.030	0.207	1.14	0.237	/
Right Cheek	standard	1RB	49	20600/844	23.50	22.92	0.000	0.351	1.14	0.401	3
Right Tilt	standard	1RB	49	20600/844	23.50	22.92	0.050	0.212	1.14	0.242	/
Left Cheek	standard	50%RB	0	20525/836.5	22.50	21.95	0.021	0.240	1.14	0.272	/
Left Tilt	standard	50%RB	0	20525/836.5	22.50	21.95	0.110	0.127	1.14	0.144	/
Right Cheek	standard	50%RB	0	20525/836.5	22.50	21.95	0.021	0.232	1.14	0.263	/
Right Tilt	standard	50%RB	0	20525/836.5	22.50	21.95	0.080	0.125	1.14	0.142	/
Body SAR (QPSK, Distance 10mm)											
Back Side	standard	1RB	49	20600/844	23.50	22.92	-0.110	0.405	1.14	0.463	4
Front Side	standard	1RB	49	20600/844	23.50	22.92	-0.010	0.298	1.14	0.341	/
Left Edge	standard	1RB	49	20600/844	23.50	22.92	0.030	0.295	1.14	0.337	/
Right Edge	standard	1RB	49	20600/844	23.50	22.92	0.020	0.341	1.14	0.390	/
Top Edge	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A
Bottom Edge	standard	1RB	49	20600/844	23.50	22.92	0.140	0.248	1.14	0.283	/
Back Side	standard	50%RB	0	20525/836.5	22.50	21.95	0.020	0.262	1.14	0.297	/
Front Side	standard	50%RB	0	20525/836.5	22.50	21.95	0.020	0.162	1.14	0.184	/
Left Edge	standard	50%RB	0	20525/836.5	22.50	21.95	0.030	0.151	1.14	0.171	/
Right Edge	standard	50%RB	0	20525/836.5	22.50	21.95	0.030	0.164	1.14	0.186	/
Top Edge	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A
Bottom Edge	standard	50%RB	0	20525/836.5	22.50	21.95	0.150	0.164	1.14	0.186	/

Note: 1.The value with blue color is the maximum SAR Value of each test band.

2. Per FCC KDB Publication 447498 D01, if the reported (scaled) SAR measured at the middle channel or highest output power channel for each test configuration is ≤ 0.8 W/kg then testing at the other channels is not required for such test configuration(s).

3. For QPSK with 100% RB allocation, SAR is required when and the highest reported SAR for 1 RB and 50% RB allocation in are ≥ 0.8 W/kg.

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10.3 Simultaneous Transmission Analysis

Simultaneous Transmission Configurations	Head	Body-worn	Hotspot
LTE(Data) + Bluetooth(data)	N/A	Yes	N/A
LTE(Data) + Wi-Fi-2.4GHz(data)	Yes	Yes	Yes
Wi-Fi-2.4GHz(data) + Bluetooth(data)	N/A	N/A	N/A

General Note:

1. The Scaled SAR summation is calculated based on the same configuration and test position.
2. Per KDB 447498 D01, simultaneous transmission SAR is compliant if,

i) Scalar SAR summation < 1.6W/kg, simultaneously transmission SAR measurement is not necessary.

ii) SPLSR = (SAR1 + SAR2)^1.5 / (min. separation distance, mm), and the peak separation distance is determined from the square root of [(x1-x2)2 + (y1-y2)2 + (z1-z2)2], where (x1, y1, z1) and (x2, y2, z2) are the coordinates of the extrapolated peak SAR locations in the zoom scan.

iii) If SPLSR ≤ 0.04, simultaneously transmission SAR measurement is not necessary.

About BT and LTE Band 5

SAR_{1g}(W/kg) / Test Position	LTE Band 5	BT	MAX. ΣSAR_{1g}
Head SAR	0.401	0.180	0.581
Body SAR	0.463	0.091	0.554
Note: 1.The value with blue color is the maximum ΣSAR_{1g} Value. 2. MAX. ΣSAR_{1g} =Unlicensed SAR_{MAX} +Licensed SAR_{MAX}			

MAX. ΣSAR_{1g} = 0.581 W/kg <1.6 W/kg, so the Simultaneous transimition SAR with volum scan are not required for BT and LTE Band 5.

About Wi-Fi and LTE Band 5

SAR_{1g}(W/kg) / Test Position	LTE Band 5	Wi-Fi 2.4G	MAX. ΣSAR_{1g}
Head SAR	0.401	0.504	0.905
Body SAR	0.463	0.096	0.559
Note: 1.The value with blue color is the maximum ΣSAR_{1g} Value. 2. MAX. ΣSAR_{1g} =Unlicensed SAR_{MAX} +Licensed SAR_{MAX}			

MAX. ΣSAR_{1g} = 0.905 W/kg <1.6 W/kg, so the Simultaneous transimition SAR with volum scan are not required for Wi-Fi and LTE Band 5.

Note: This is a C2PC application which only open the LTE Band 5 via changing the software. The BT/WiFi SAR value is according to the SAR Report No. 2017SAR025, which the FCC ID is SRQ-BLADEV8SE, originally granted on 02/25/2017.

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11 Measurement Uncertainty

Per KDB 865664 D01 SAR Measurement 100 MHz to 6 GHz, when the highest measured 1-g SAR within a frequency band is < 1.5 W/kg, the extensive SAR measurement uncertainty analysis described in IEEE Std 1528- 2013 is not required in SAR reports submitted for equipment approval. This also applies to the 10-g SAR required for phablets in KDB Publication 648474.

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ANNEX A: Test Layout

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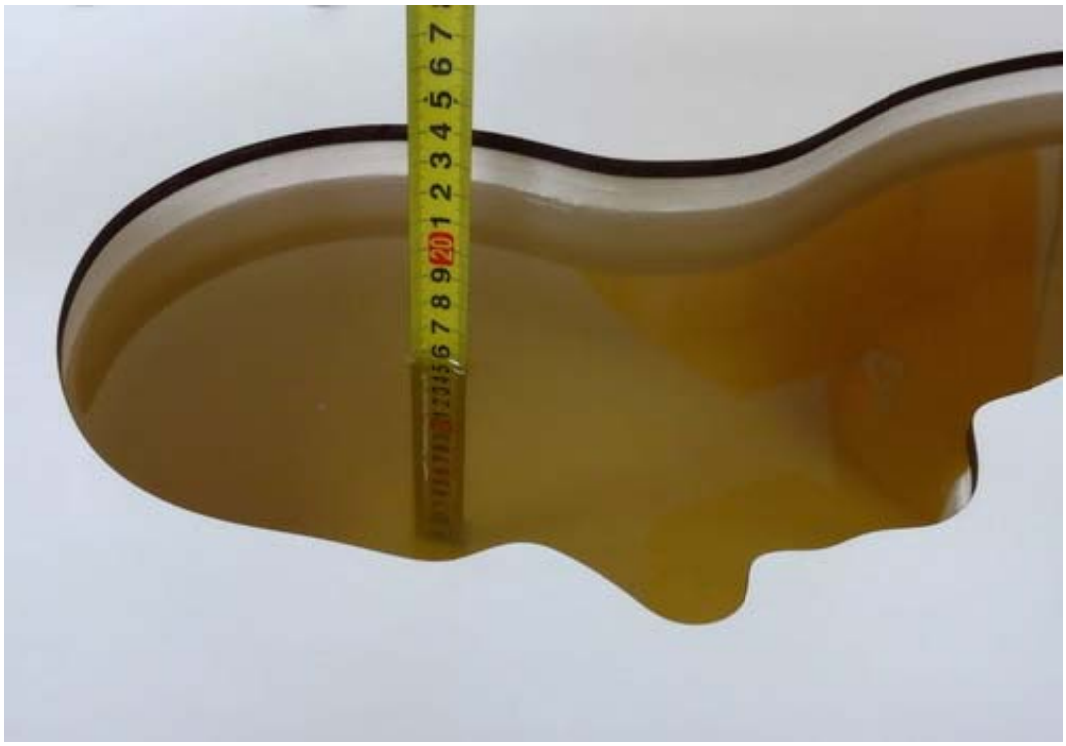

Picture 3: Liquid depth in the head Phantom (835MHz, 15.3cm depth)

Picture 4: Liquid depth in the flat Phantom (835MHz, 15.4cm depth)

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ANNEX B: System Check Results

Plot 1 System Performance Check at 835 MHz Head TSL

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN: 4d020

Date: 7/25/2017

Communication System: CW; Frequency: 835 MHz;Duty Cycle: 1:1

Medium parameters used: f = 835 MHz; σ = 0.94 mho/m; ε_r = 42.5; ρ = 1000 kg/m^3

Ambient Temperature:22.3 ℃ Liquid Temperature: 21.5℃

Phantom section: Flat Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3677; ConvF(9.31, 9.31, 9.31); Calibrated: 1/23/2017;

Electronics: DAE4 Sn1317; Calibrated: 8/2/2016

Phantom: SAM1; Type: SAM; Serial: TP-1534

Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

d=15mm, Pin=250mW/Area Scan (41x121x1): Measurement grid: dx=1.500 mm, dy=1.500 mm

Maximum value of SAR (interpolated) = 2.64 mW/g

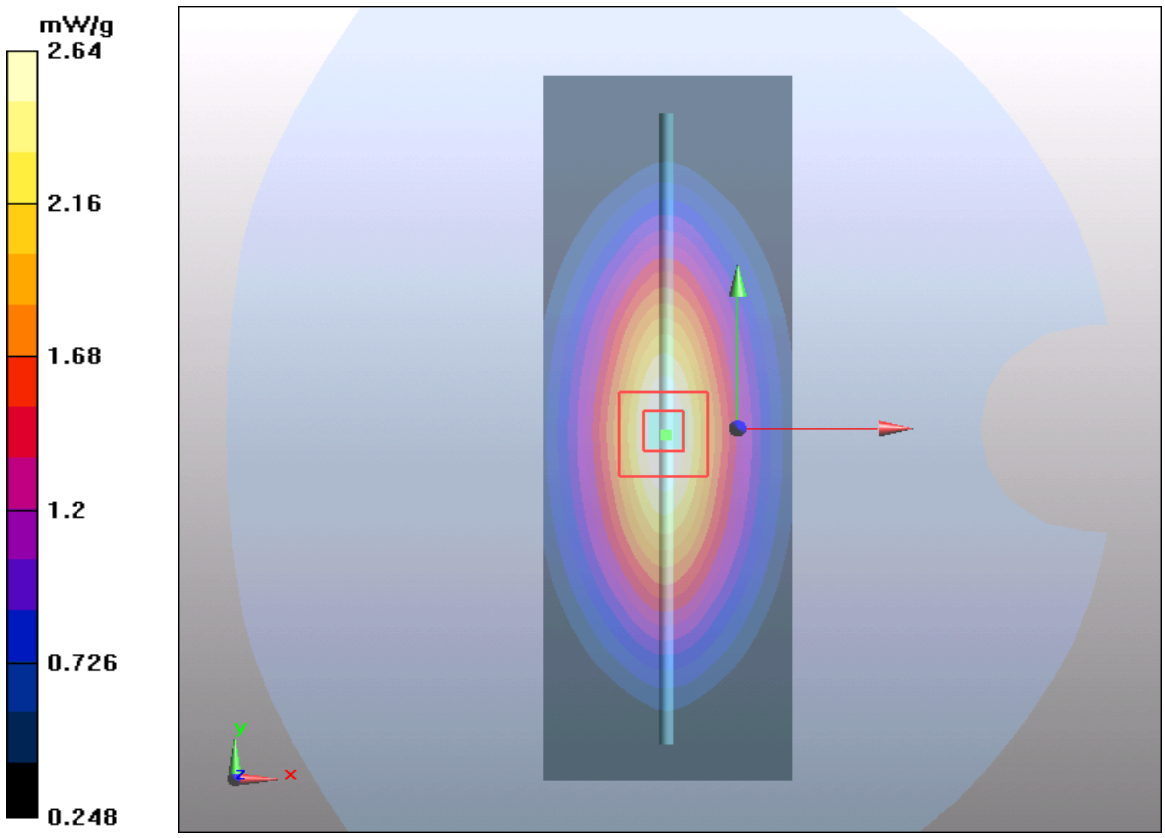
d=15mm, Pin=250mW/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 54.4 V/m; Power Drift = -0.076 dB

Peak SAR (extrapolated) = 3.67 W/kg

SAR(1 g) = 2.44 mW/g; SAR(10 g) = 1.6 mW/g

Maximum value of SAR (measured) = 2.64 mW/g



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Plot 2 System Performance Check at 835 MHz Body TSL

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN: 4d020

Date: 7/25/2017

Communication System: CW; Frequency: 835 MHz;Duty Cycle: 1:1

Medium parameters used: f = 835 MHz; σ = 0.96 mho/m; ε_r = 55.4; ρ = 1000 kg/m^3

Ambient Temperature:22.3 ℃ Liquid Temperature: 21.5℃

Phantom section: Flat Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3677; ConvF(9.74, 9.74, 9.74); Calibrated: 1/23/2017;

Electronics: DAE4 Sn1317; Calibrated: 8/2/2016

Phantom: SAM1; Type: SAM; Serial: TP-1534

Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

d=15mm, Pin=250mW/Area Scan (41x121x1): Measurement grid: dx=1.500 mm, dy=1.500 mm

Maximum value of SAR (interpolated) = 2.58 mW/g

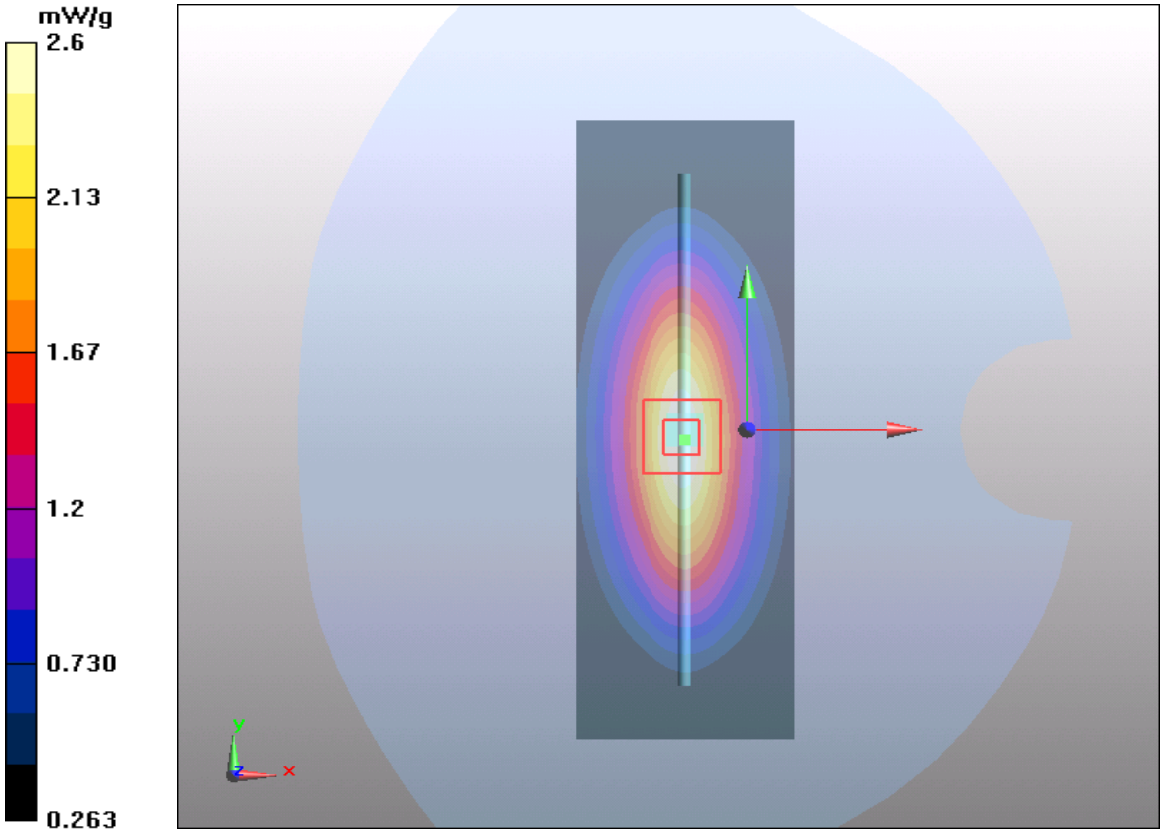
d=15mm, Pin=250mW/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 51.9 V/m; Power Drift = -0.058 dB

Peak SAR (extrapolated) = 3.5 W/kg

SAR(1 g) = 2.41 mW/g; SAR(10 g) = 1.6 mW/g

Maximum value of SAR (measured) = 2.6 mW/g



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ANNEX C: Highest Graph Results

Plot 3 LTE Band 5 1RB Right Cheek High

Date: 7/25/2017

Communication System: UID 0, LTE_FDD (0); Frequency: 844 MHz;Duty Cycle: 1:1

Medium parameters used: f = 844 MHz; σ = 0.933 S/m; ε_r = 41.913; ρ = 1000 kg/m^3

Ambient Temperature:22.3 ℃ Liquid Temperature: 21.5℃

Phantom section: Right Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3677; ConvF(9.31, 9.31, 9.31); Calibrated: 1/23/2017;

Electronics: DAE4 Sn1317; Calibrated: 8/2/2016

Phantom: SAM 2; Type: SAM;

Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

Right Cheek High/Area Scan (71x121x1): Interpolated grid: dx=1.500 mm, dy=1.500 mm

Maximum value of SAR (interpolated) = 0.366 W/kg

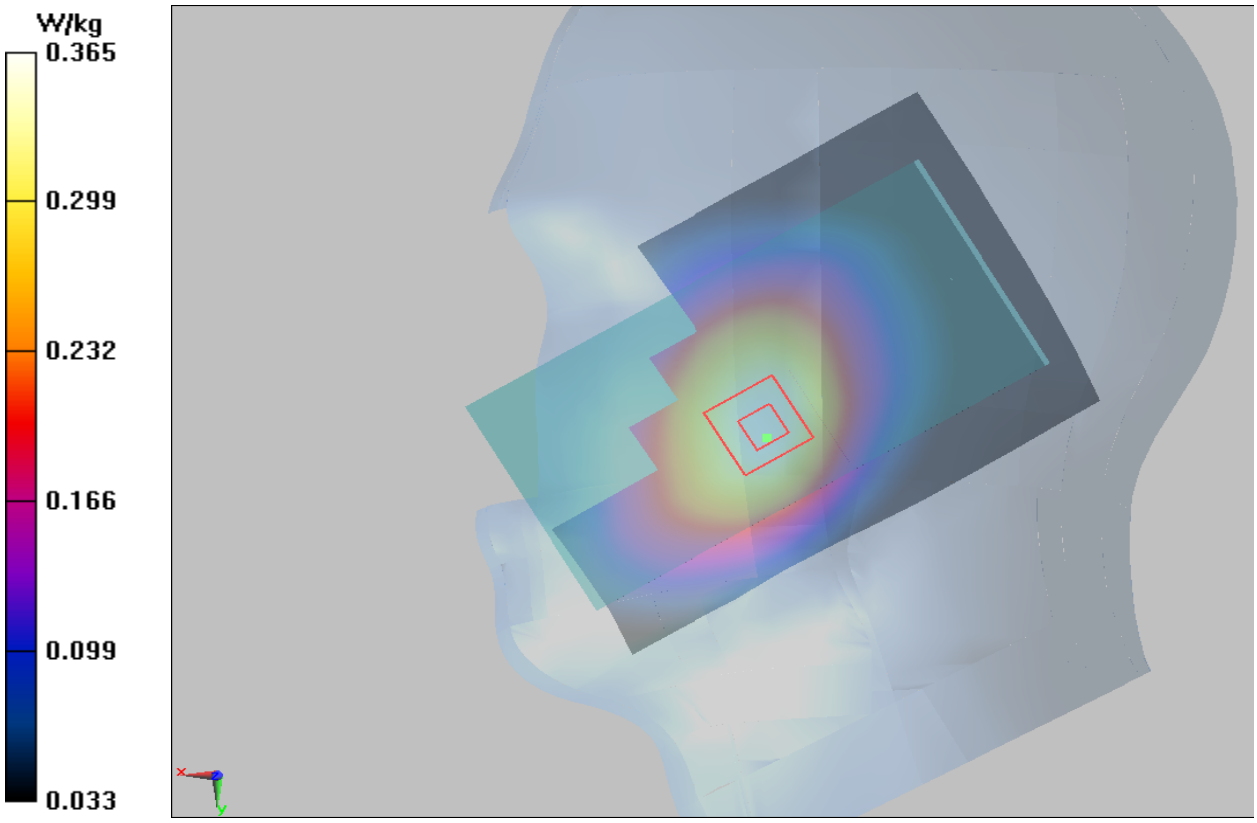
Right Cheek High/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 6.424 V/m; Power Drift = 0.00 dB

Peak SAR (extrapolated) = 0.440 W/kg

SAR(1 g) = 0.351 W/kg; SAR(10 g) = 0.264 W/kg

Maximum value of SAR (measured) = 0.365 W/kg



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Plot 4 LTE Band 5 1RB Back Side High (Distance 10mm)

Date: 7/25/2017

Communication System: UID 0, LTE_FDD (0); Frequency: 844 MHz;Duty Cycle: 1:1

Medium parameters used: f = 844 MHz; σ = 1.035 S/m; ε_r = 55.274; ρ = 1000 kg/m^3

Ambient Temperature:22.3 ℃ Liquid Temperature: 21.5℃

Phantom section: Flat Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3677; ConvF(9.74, 9.74, 9.74); Calibrated: 1/23/2017;

Electronics: DAE4 Sn1317; Calibrated: 8/2/2016

Phantom: SAM1; Type: SAM; Serial: TP-1534

Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7331)

Back Side High/Area Scan (71x121x1): Interpolated grid: dx=1.500 mm, dy=1.500 mm

Maximum value of SAR (interpolated) = 0.423 W/kg

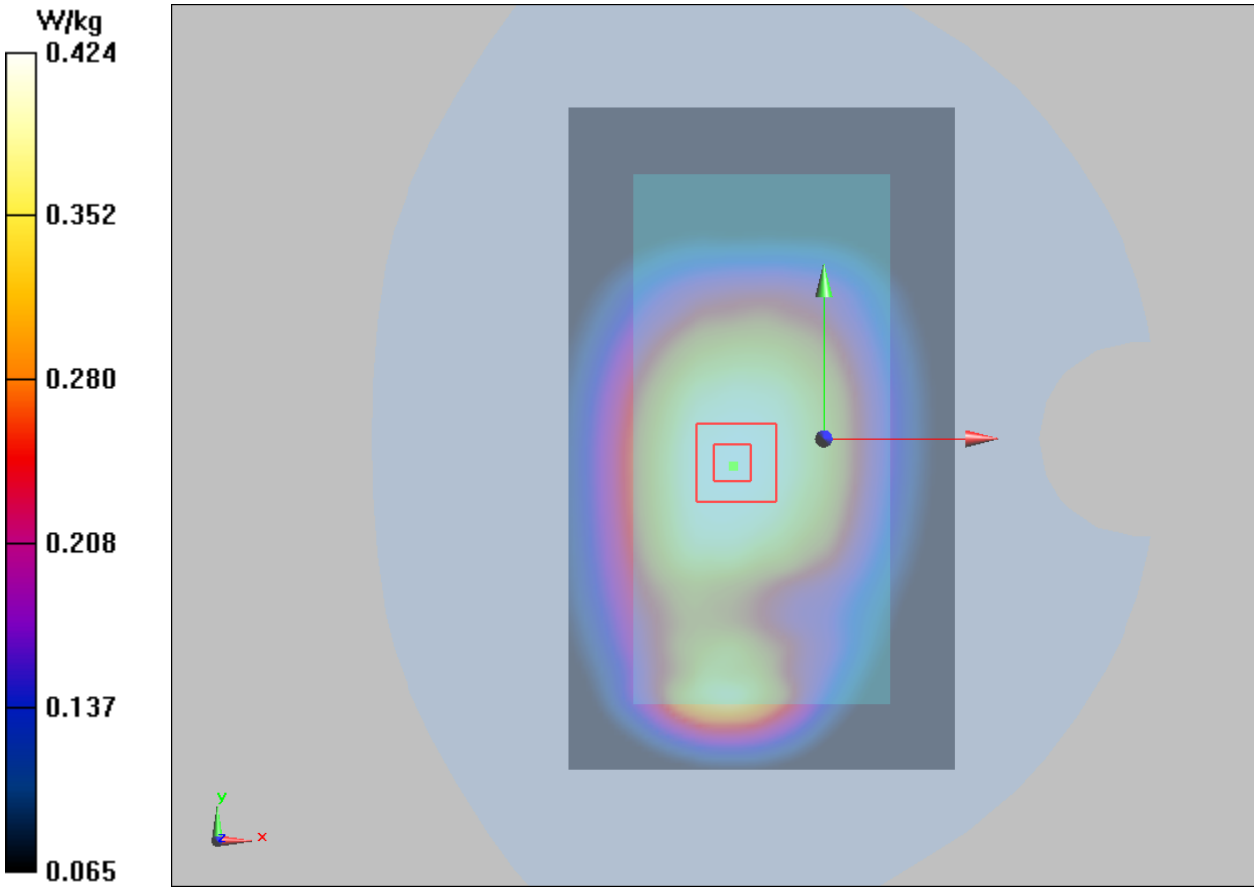
Back Side High/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 20.59 V/m; Power Drift = -0.11 dB

Peak SAR (extrapolated) = 0.499 W/kg

SAR(1 g) = 0.405 W/kg; SAR(10 g) = 0.312 W/kg

Maximum value of SAR (measured) = 0.424 W/kg



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ANNEX D: Probe Calibration Certificate

In Collaboration with
s p e a g
CALIBRATION LABORATORY
Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China
Tel: +86-10-62304633-2218 Fax: +86-10-62304633-2209
E-mail: cttl@chinattl.com Http://www.chinattl.cn

中国认可
国际互认
校准
CALIBRATION
CNAS L0570

Client TA(Shanghai) Certificate No: Z17-97012

CALIBRATION CERTIFICATE

Object	EX3DV4 - SN:3677
Calibration Procedure(s)	FD-Z11-004-01 Calibration Procedures for Dosimetric E-field Probes
Calibration date:	January 23, 2017

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)°C and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Power Meter NRP2	101919	27-Jun-16 (CTTL, No.J16X04777)	Jun-17
Power sensor NRP-Z91	101547	27-Jun-16 (CTTL, No.J16X04777)	Jun-17
Power sensor NRP-Z91	101548	27-Jun-16 (CTTL, No.J16X04777)	Jun-17
Reference10dBAttenuator	18N50W-10dB	13-Mar-16(CTTL,No.J16X01547)	Mar-18
Reference20dBAttenuator	18N50W-20dB	13-Mar-16(CTTL, No.J16X01548)	Mar-18
Reference Probe EX3DV4	SN 7433	26-Sep-16(SPEAG,No.EX3-7433_Sep16)	Sep-17
DAE4	SN 549	13-Dec-16(SPEAG, No.DAE4-549_Dec16)	Dec -17
Secondary Standards	**ID #**	**Cal Date(Calibrated by, Certificate No.)**	**Scheduled Calibration**
SignalGeneratorMG3700A	6201052605	27-Jun-16 (CTTL, No.J16X04776)	Jun-17
Network Analyzer E5071C	MY46110673	26-Jan-16 (CTTL, No.J16X00894)	Jan -17

	Name	Function	Signature
Calibrated by:	Yu Zongying	SAR Test Engineer	
Reviewed by:	Qi Dianyuan	SAR Project Leader	
Approved by:	Lu Bingsong	Deputy Director of the laboratory	

Issued: January 24, 2017

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Certificate No: Z17-97012 Page 1 of 11

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Glossary:

TSL	tissue simulating liquid
NORMx,y,z	sensitivity in free space
ConvF	sensitivity in TSL / NORMx,y,z
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A,B,C,D	modulation dependent linearization parameters
Polarization Φ	Φ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i θ=0 is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013

b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005

c) IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010

d) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- *NORMx,y,z:* Assessed for E-field polarization θ=0 (f≤900MHz in TEM-cell; f>1800MHz: waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E^2-field uncertainty inside TSL (see below ConvF).
- *NORM(f)x,y,z = NORMx,y,z* frequency_response* (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- *DCPx,y,z:* DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics.
- *Ax,y,z; Bx,y,z; Cx,y,z;VRx,y,z:*A,B,C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- *ConvF and Boundary Effect Parameters:* Assessed in flat phantom using E-field (or Temperature Transfer Standard for f≤800MHz) and inside waveguide using analytical field distributions based on power measurements for f >800MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty valued are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from±50MHz to±100MHz.
- *Spherical isotropy (3D deviation from isotropy):* in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- *Sensor Offset:* The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- *Connector Angle:* The angle is assessed using the information gained by determining the *NORMx* (no uncertainty required).

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Probe EX3DV4

SN: 3677

Calibrated: January 23, 2017

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)

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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 3677

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm(μV/(V/m)^2)[A]	0.39	0.44	0.38	±10.8%
DCP(mV)[B]	97.3	102.2	101.1	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dB√μV	C	D dB	VR mV	Unc[E] (k=2)
0	CW	X	0.0	0.0	1.0	0.00	180.5	±2.0%
		Y	0.0	0.0	1.0		195.3	
		Z	0.0	0.0	1.0		177.9	

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

[A] The uncertainties of Norm X, Y, Z do not affect the E^2-field uncertainty inside TSL (see Page 5 and Page 6).
[B] Numerical linearization parameter: uncertainty not required.
[E] Uncertainly is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 3677

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz][C]	Relative Permittivity[F]	Conductivity (S/m)[F]	ConvF X	ConvF Y	ConvF Z	Alpha[G]	Depth[G] (mm)	Unct. (k=2)
750	41.9	0.89	9.58	9.58	9.58	0.30	0.75	±12%
835	41.5	0.90	9.31	9.31	9.31	0.11	1.55	±12%
1750	40.1	1.37	8.60	8.60	8.60	0.24	1.07	±12%
1900	40.0	1.40	8.39	8.39	8.39	0.23	1.10	±12%
2300	39.5	1.67	8.13	8.13	8.13	0.53	0.74	±12%
2450	39.2	1.80	7.90	7.90	7.90	0.61	0.71	±12%
2600	39.0	1.96	7.64	7.64	7.64	0.68	0.68	±12%
5250	35.9	4.71	5.66	5.66	5.66	0.40	1.20	±13%
5600	35.5	5.07	4.99	4.99	4.99	0.40	1.40	±13%
5750	35.4	5.22	5.00	5.00	5.00	0.40	1.40	±13%

[C] Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

[F] At frequency below 3 GHz, the validity of tissue parameters (ε and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ε and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

[G] Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 3677

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz][C]	Relative Permittivity[F]	Conductivity (S/m)[F]	ConvF X	ConvF Y	ConvF Z	Alpha[G]	Depth[G] (mm)	Unct. (k=2)
750	55.5	0.96	9.99	9.99	9.99	0.30	0.95	±12%
835	55.2	0.97	9.74	9.74	9.74	0.14	1.66	±12%
1750	53.4	1.49	8.39	8.39	8.39	0.21	1.16	±12%
1900	53.3	1.52	7.98	7.98	7.98	0.22	1.24	±12%
2300	52.9	1.81	7.97	7.97	7.97	0.55	0.80	±12%
2450	52.7	1.95	7.85	7.85	7.85	0.50	0.86	±12%
2600	52.5	2.16	7.63	7.63	7.63	0.44	0.91	±12%
5250	48.9	5.36	5.03	5.03	5.03	0.50	1.60	±13%
5600	48.5	5.77	4.34	4.34	4.34	0.54	1.66	±13%
5750	48.3	5.94	4.52	4.52	4.52	0.57	1.95	±13%

[C] Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

[F] At frequency below 3 GHz, the validity of tissue parameters (ε and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ε and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

[G] Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

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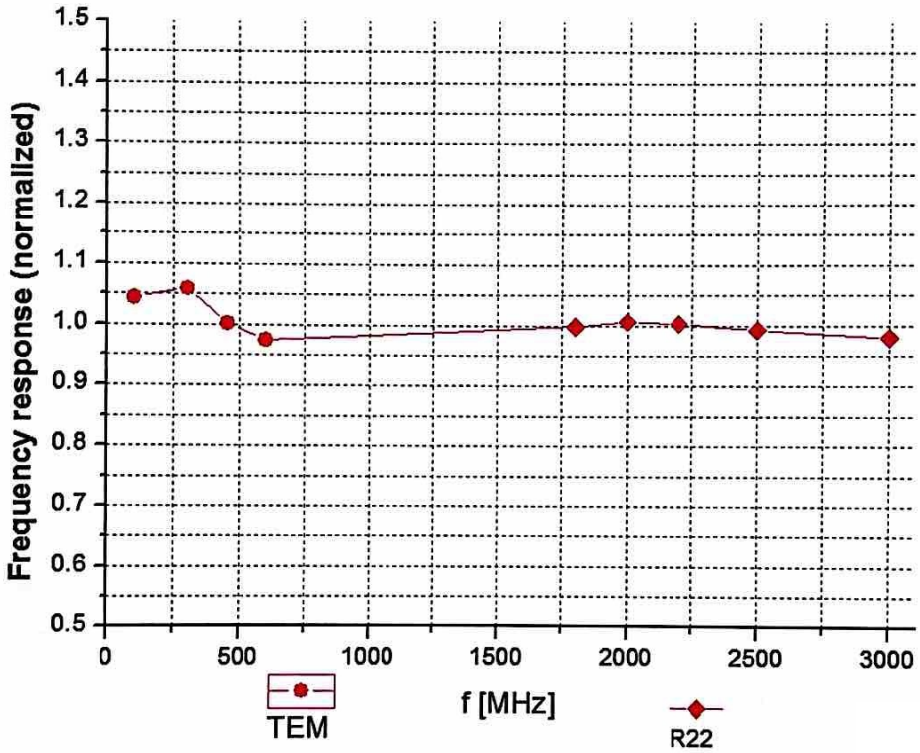
Frequency Response of E-Field
(TEM-Cell: ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ±7.5% (k=2)

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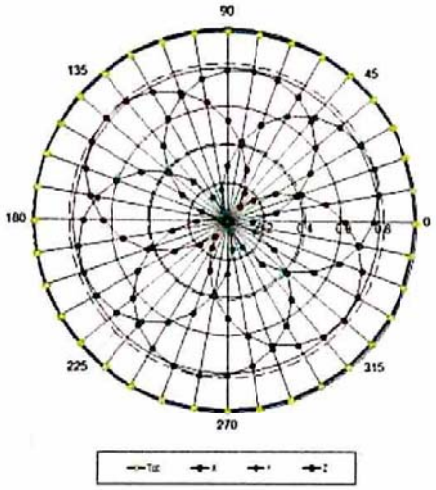
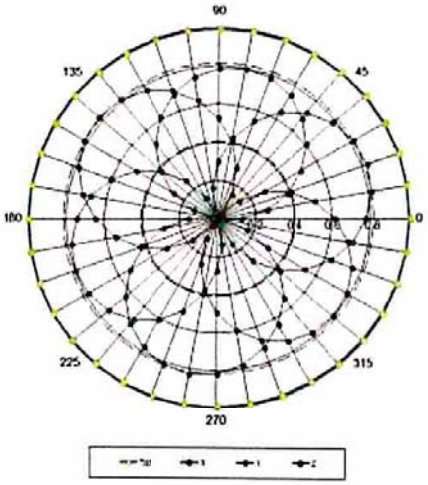
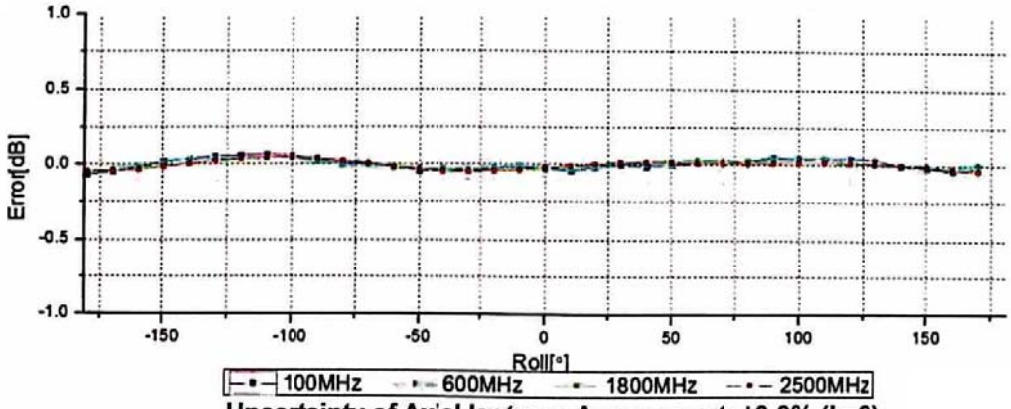
Receiving Pattern (Φ), θ=0°

f=600 MHz, TEM



f=1800 MHz, R22





Uncertainty of Axial Isotropy Assessment: ±0.9% (k=2)

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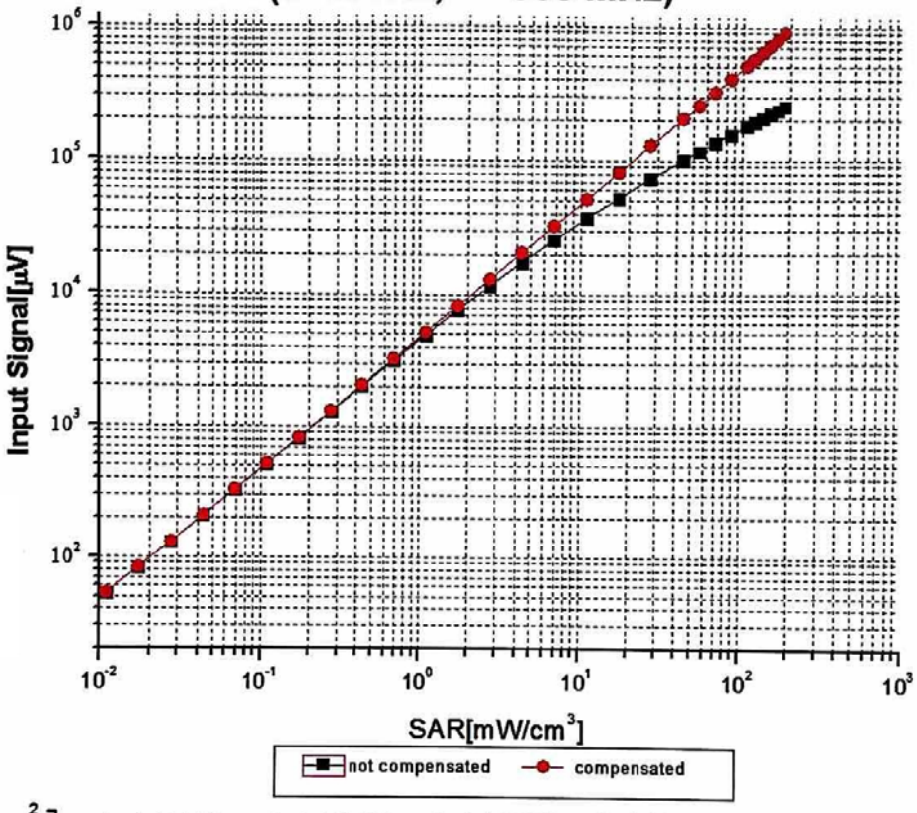
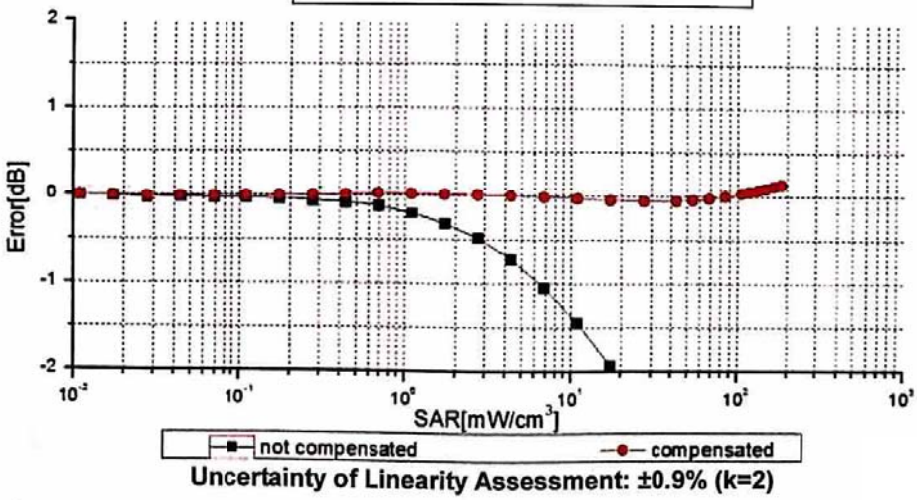
Dynamic Range f(SAR$_{head}$)
(TEM cell, f = 900 MHz)





Uncertainty of Linearity Assessment: ±0.9% (k=2)

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